

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,484	BINDRA, AMRIT P.
Examiner	Art Unit
John L. Goodrow	1756

SEARCHED					
Class	Subclass	Date	Examiner		
430	108.23	4/2/2005	JG		
106	402				
	494				
	496				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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(INCLUDING SEAR	CH STRATEGY)
	DATE	EXMR
inventor name search	4/2/2005	JG
STN library structure saerch	4/1/2005	JG
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